

## N-channel 800 V, 2.75 $\Omega$ typ., 2 A MDmesh™ K5 Power MOSFET in TO-220 and IPAK packages

Datasheet - production data

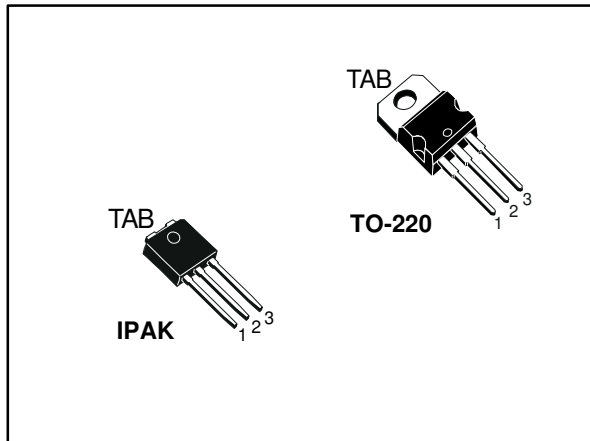
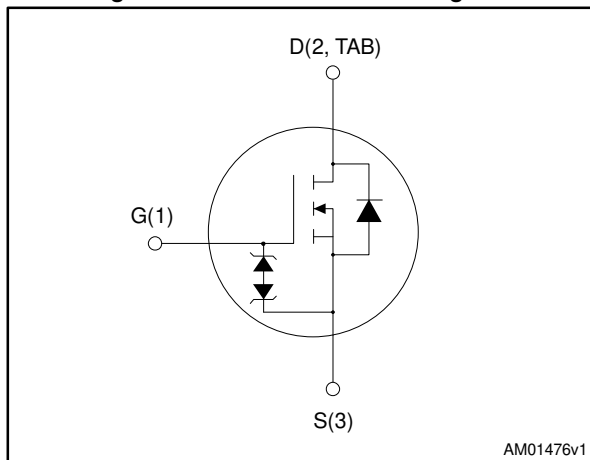


Figure 1: Internal schematic diagram



### Features

| Order code | V <sub>DS</sub> | R <sub>DS(on)</sub> max | I <sub>D</sub> |
|------------|-----------------|-------------------------|----------------|
| STP3LN80K5 | 800 V           | 3.25 $\Omega$           | 2 A            |
| STU3LN80K5 |                 |                         |                |

- Industry's lowest R<sub>DS(on)</sub> x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

### Applications

- Switching applications

### Description

These very high voltage N-channel Power MOSFET are designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

| Order code | Marking | Package | Packing |
|------------|---------|---------|---------|
| STP3LN80K5 | 3LN80K5 | TO-220  | Tube    |
| STU3LN80K5 |         | IPAK    |         |

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# 1 Electrical ratings

**Table 2: Absolute maximum ratings**

| Symbol        | Parameter   | Value       | Unit             |
|---------------|---|-------------|------------------|
| $V_{GS}$      | Gate-source voltage   | $\pm 30$    | V                |
| $I_D$         | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$  | 2           | A                |
| $I_D$         | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 1.25        | A                |
| $I_D^{(1)}$   | Drain current (pulsed)  | 8           | A                |
| $P_{TOT}$     | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$           | 45          | W                |
| $dv/dt^{(2)}$ | Peak diode recovery voltage slope                               | 4.5         | V/ns             |
| $dv/dt^{(3)}$ | MOSFET $dv/dt$ ruggedness                                       | 50          |                  |
| $T_{stg}$     | Storage temperature range                                       | - 55 to 150 | $^\circ\text{C}$ |
| $T_j$         | Operating junction temperature range                            |             |                  |

**Notes:**

(1) Pulse width limited by safe operating area.

(2)  $I_{SD} \leq 2\text{ A}$ ,  $di/dt \leq 100\text{ A}/\mu\text{s}$ ;  $V_{DSpeak} < V_{(BR)DSS}$ ,  $V_{DD} = 640\text{ V}$ .

(3)  $V_{DS} \leq 640\text{ V}$ .

**Table 3: Thermal data**

| Symbol         | Parameter                           | Value  |      | Unit                      |
|----------------|-------------------------------------|--------|------|---------------------------|
|                |                                     | TO-220 | IPAK |                           |
| $R_{thj-case}$ | Thermal resistance junction-case    | 2.78   |      | $^\circ\text{C}/\text{W}$ |
| $R_{thj-amb}$  | Thermal resistance junction-ambient | 62.5   | 100  | $^\circ\text{C}/\text{W}$ |

**Table 4: Avalanche characteristics**

| Symbol   | Parameter  | Value | Unit |
|----------|--|-------|------|
| $I_{AR}$ | Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )                                 | 0.7   | A    |
| $E_{AS}$ | Single pulse avalanche energy (starting $T_j = 25\text{ }^\circ\text{C}$ , $I_D = I_{AR}$ ; $V_{DD} = 50\text{ V}$ ) | 155   | mJ   |

## 2 Electrical characteristics

( $T_C = 25\text{ °C}$  unless otherwise specified)

**Table 5: On /off states**

| Symbol        | Parameter                         | Test conditions  | Min. | Typ. | Max.     | Unit          |
|---------------|-----------------------------------|--|------|------|----------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage    | $I_D = 1\text{ mA}$ , $V_{GS} = 0\text{ V}$                                      | 800  |      |          | V             |
| $I_{DSS}$     | Zero gate voltage drain current   | $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$                                  |      |      | 1        | $\mu\text{A}$ |
|               |                                   | $V_{DS} = 800\text{ V}$ , $V_{GS} = 0\text{ V}$ ,<br>$T_C = 125\text{ °C}^{(1)}$ |      |      | 50       | $\mu\text{A}$ |
| $I_{GSS}$     | Gate body leakage current         | $V_{GS} = \pm 20\text{ V}$ , $V_{DS} = 0\text{ V}$                               |      |      | $\pm 10$ | $\mu\text{A}$ |
| $V_{GS(th)}$  | Gate threshold voltage            | $V_{DS} = V_{GS}$ , $I_D = 100\text{ }\mu\text{A}$                               | 3    | 4    | 5        | V             |
| $R_{DS(on)}$  | Static drain-source on-resistance | $V_{GS} = 10\text{ V}$ , $I_D = 1\text{ A}$                                      |      | 2.75 | 3.25     | $\Omega$      |

**Notes:**

<sup>(1)</sup>Defined by design, not subject to production test.

**Table 6: Dynamic**

| Symbol          | Parameter                             | Test conditions   | Min. | Typ. | Max. | Unit     |
|-----------------|---------------------------------------|---|------|------|------|----------|
| $C_{iss}$       | Input capacitance                     | $V_{DS} = 100\text{ V}$ , $f = 1\text{ MHz}$ ,<br>$V_{GS} = 0\text{ V}$   | -    | 102  | -    | pF       |
| $C_{oss}$       | Output capacitance                    |   | -    | 11   | -    | pF       |
| $C_{rss}$       | Reverse transfer capacitance          |   | -    | 0.1  | -    | pF       |
| $C_{otr}^{(1)}$ | Equivalent capacitance time related   | $V_{DS} = 0\text{ to }640\text{ V}$ , $V_{GS} = 0\text{ V}$   | -    | 20   | -    | pF       |
| $C_{oer}^{(2)}$ | Equivalent capacitance energy related |   | -    | 7    | -    | pF       |
| $R_G$           | Intrinsic gate resistance             | $f = 1\text{ MHz}$ , $I_D = 0\text{ A}$   | -    | 12   | -    | $\Omega$ |
| $Q_g$           | Total gate charge                     | $V_{DD} = 640\text{ V}$ , $I_D = 2\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$ ( see <a href="#">Figure 17: "Test circuit for gate charge behavior"</a> ) | -    | 2.63 | -    | nC       |
| $Q_{gs}$        | Gate-source charge                    |   | -    | 0.91 | -    | nC       |
| $Q_{gd}$        | Gate-drain charge                     |   | -    | 1.53 | -    | nC       |

**Notes:**

<sup>(1)</sup>Time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

<sup>(2)</sup>Energy related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

Table 7: Switching times

| Symbol       | Parameter           | Test conditions  | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 400\text{ V}$ , $I_D = 1\text{ A}$ , $R_G = 4.7\ \Omega$ ,<br>$V_{GS} = 10\text{ V}$ ( see <a href="#">Figure 16: "Test circuit for resistive load switching times"</a> and <a href="#">Figure 21: "Switching time waveform"</a> ) | -    | 6.2  | -    | ns   |
| $t_r$        | Rise time           |  | -    | 7    | -    | ns   |
| $t_{d(off)}$ | Turn-off delay time |  | -    | 30   | -    | ns   |
| $t_f$        | Fall time           |  | -    | 26   | -    | ns   |

Table 8: Source drain diode

| Symbol          | Parameter                     | Test conditions   | Min. | Typ. | Max. | Unit          |
|-----------------|-------------------------------|---|------|------|------|---------------|
| $I_{SD}$        | Source-drain current          |   | -    |      | 2    | A             |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |   | -    |      | 8    | A             |
| $V_{SD}^{(2)}$  | Forward on voltage            | $I_{SD} = 2\text{ A}$ , $V_{GS} = 0\text{ V}$   | -    |      | 1.5  | V             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 2\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 60\text{ V}$ ( see <a href="#">Figure 18: "Test circuit for inductive load switching and diode recovery times"</a> )                                      | -    | 210  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 0.8  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 7.6  |      | A             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 2\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ ,<br>$V_{DD} = 60\text{ V}$ , $T_J = 150\text{ }^\circ\text{C}$ , (see <a href="#">Figure 18: "Test circuit for inductive load switching and diode recovery times"</a> ) | -    | 345  |      | ns            |
| $Q_{rr}$        | Reverse recovery charge       |   | -    | 1.2  |      | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      |   | -    | 7.2  |      | A             |

**Notes:**

(1)Pulse width limited by safe operating area.

(2)Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

Table 9: Gate-source Zener diode

| Symbol        | Parameter                     | Test conditions                                 | Min. | Typ. | Max. | Unit |
|---------------|-------------------------------|---|------|------|------|------|
| $V_{(BR)GSO}$ | Gate-source breakdown voltage | $I_{GS} = \pm 1\text{ mA}$ , $I_D = 0\text{ A}$ | 30   | -    | -    | V    |

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

## 2.1 Electrical characteristics (curves)

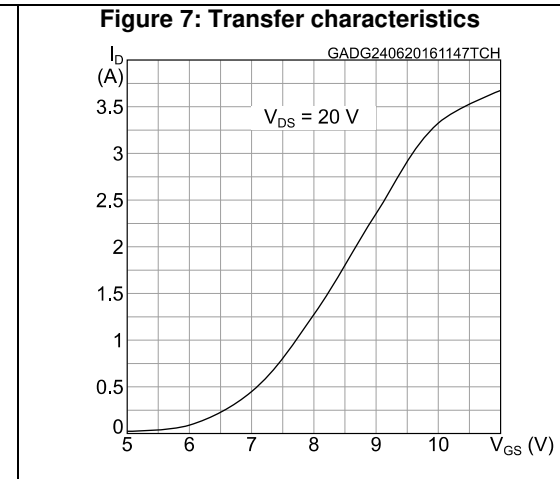
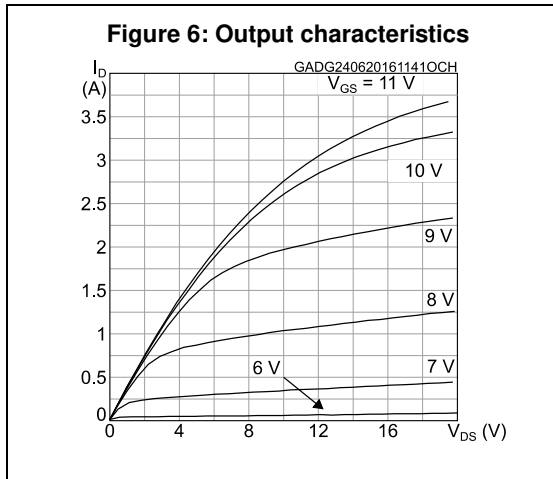
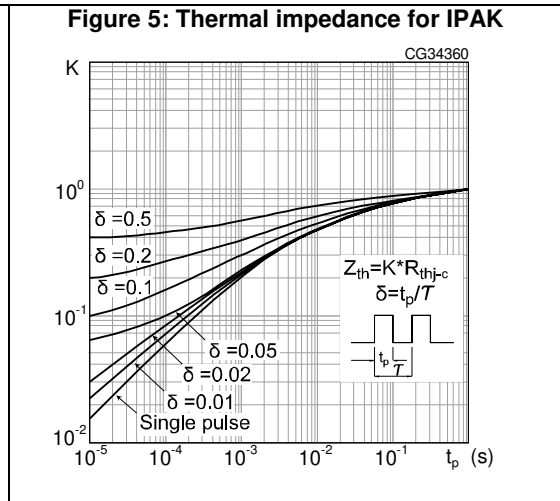
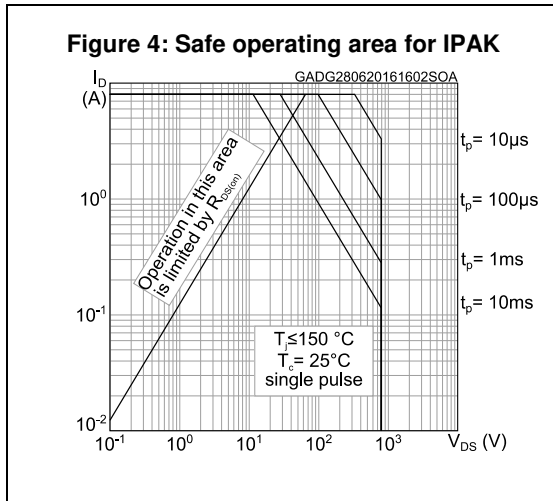
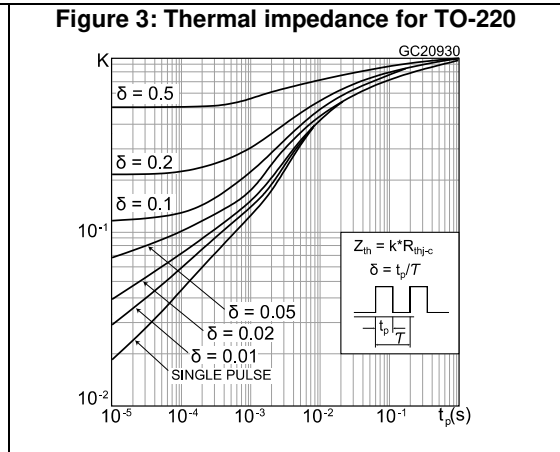
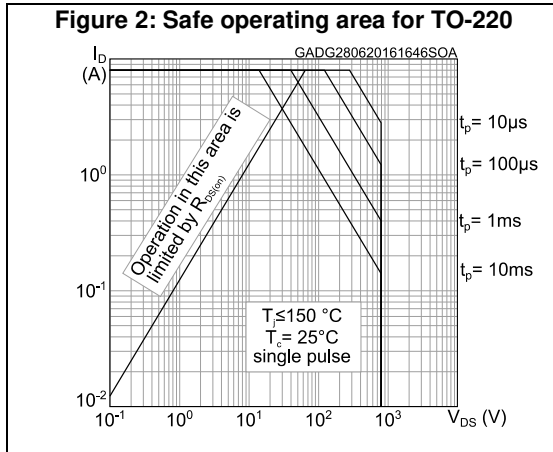


Figure 8: Gate charge vs gate-source voltage

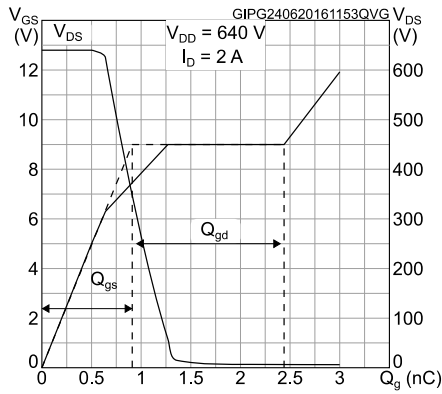


Figure 9: Static drain-source on-resistance

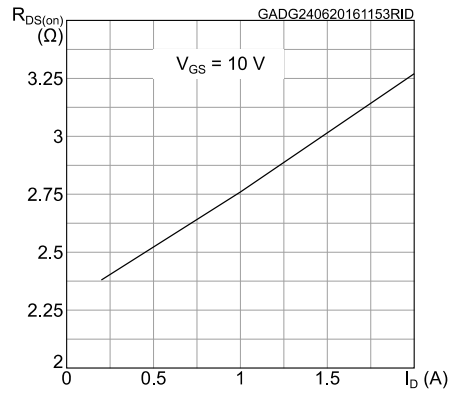


Figure 10: Capacitance variations

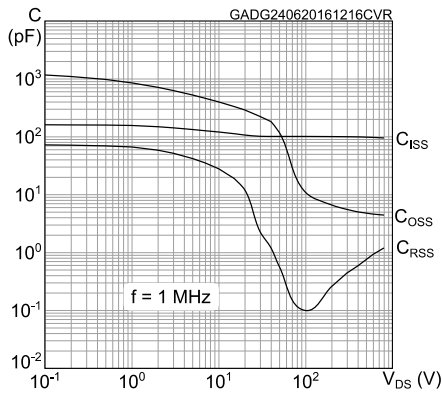


Figure 11: Source-drain diode forward characteristics

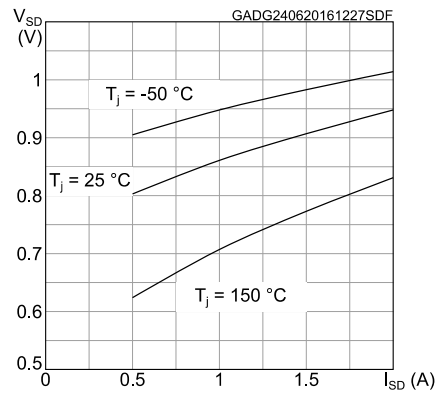


Figure 12: Normalized gate threshold voltage vs temperature

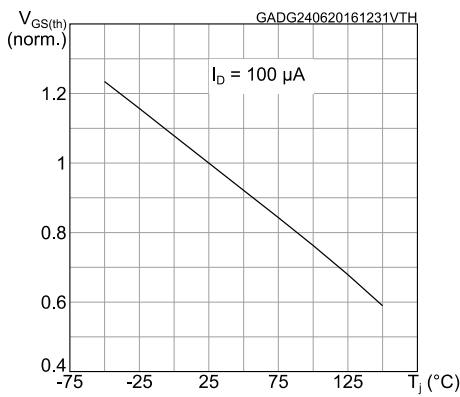


Figure 13: Normalized on-resistance vs temperature

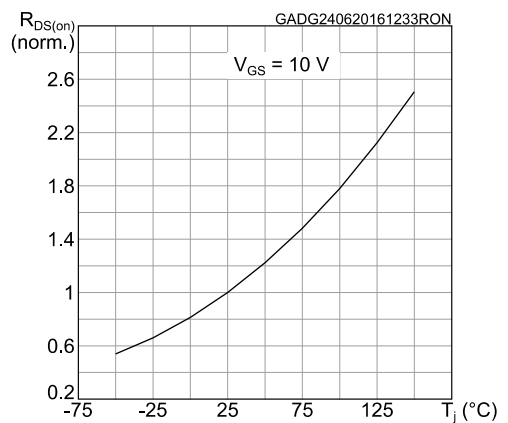


Figure 14: Normalized  $V_{(BR)DSS}$  vs temperature

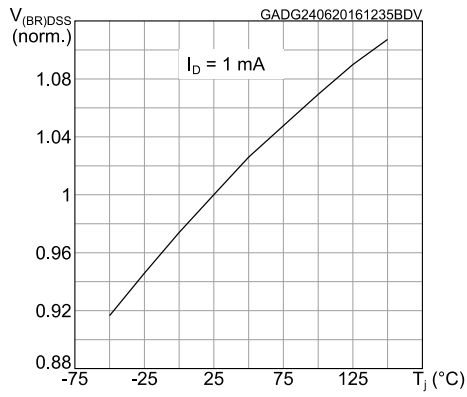
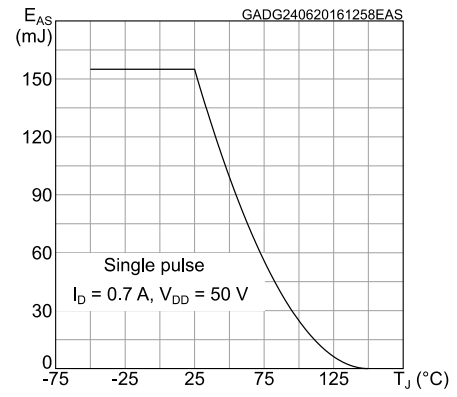


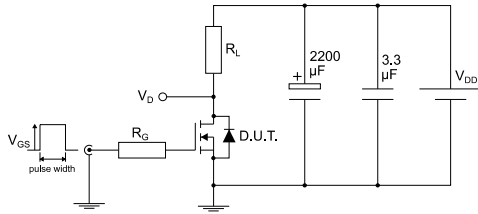
Figure 15: Maximum avalanche energy vs starting  $T_J$





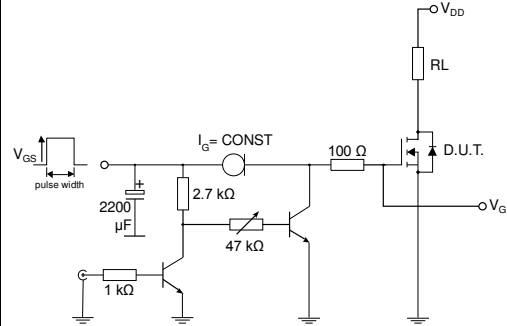
### 3 Test circuits

**Figure 16: Test circuit for resistive load switching times**



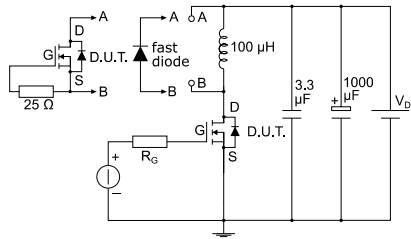
AM01468v1

**Figure 17: Test circuit for gate charge behavior**



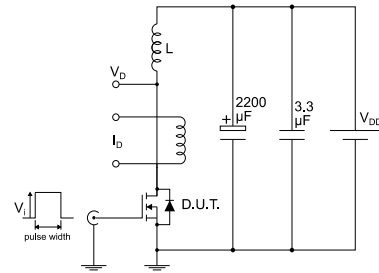
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**Figure 18: Test circuit for inductive load switching and diode recovery times**



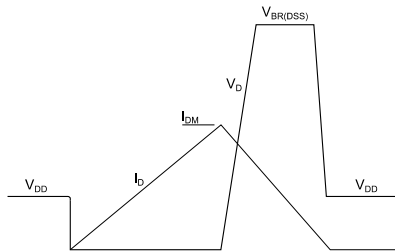
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**Figure 19: Unclamped inductive load test circuit**



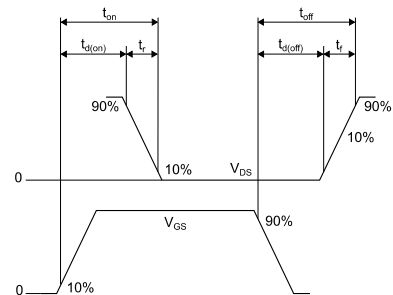
AM01471v1

**Figure 20: Unclamped inductive waveform**



AM01472v1

**Figure 21: Switching time waveform**



AM01473v1

## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 4.1 IPAK package information

Figure 22: IPAK (TO-251) type A package outline

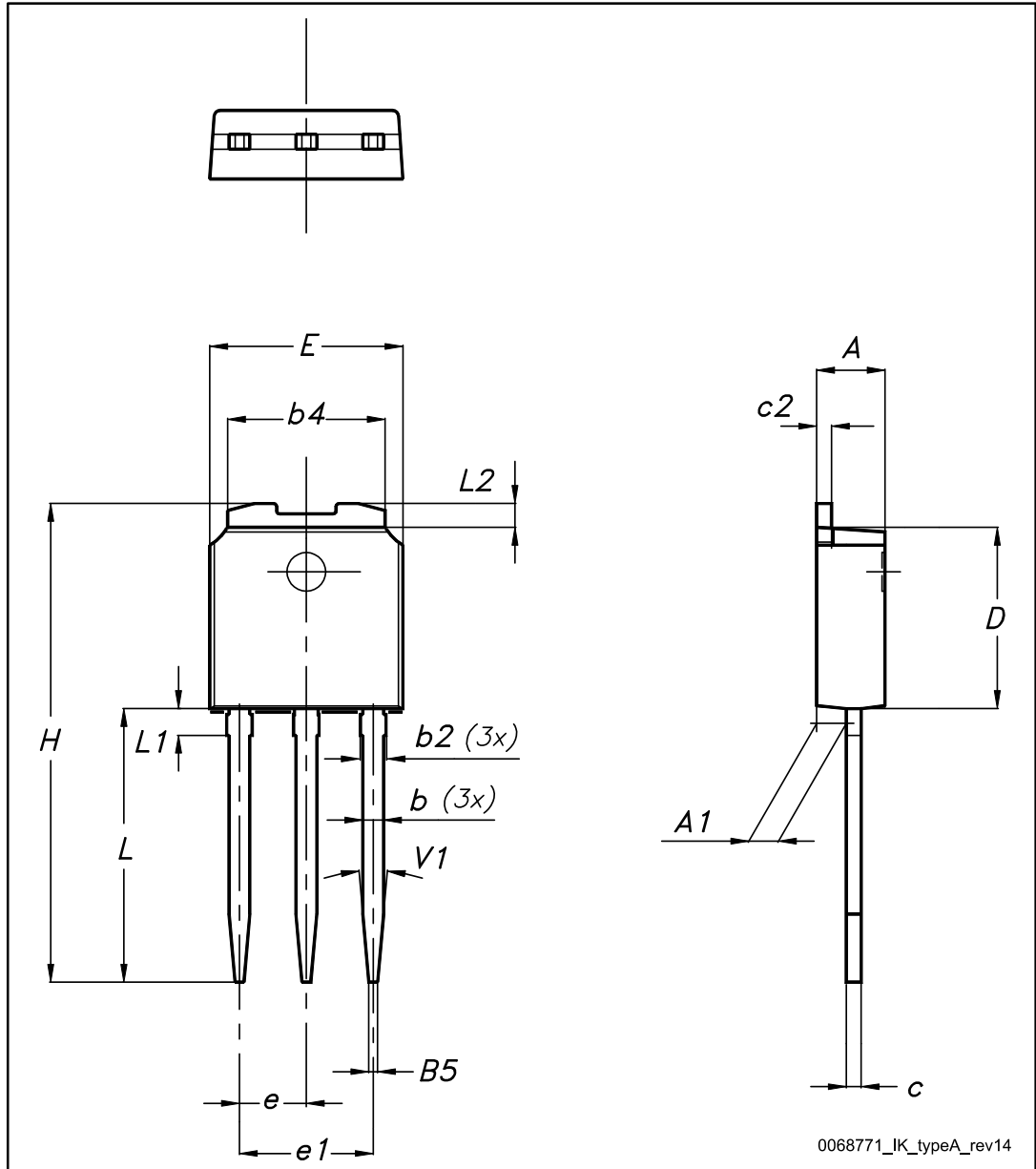
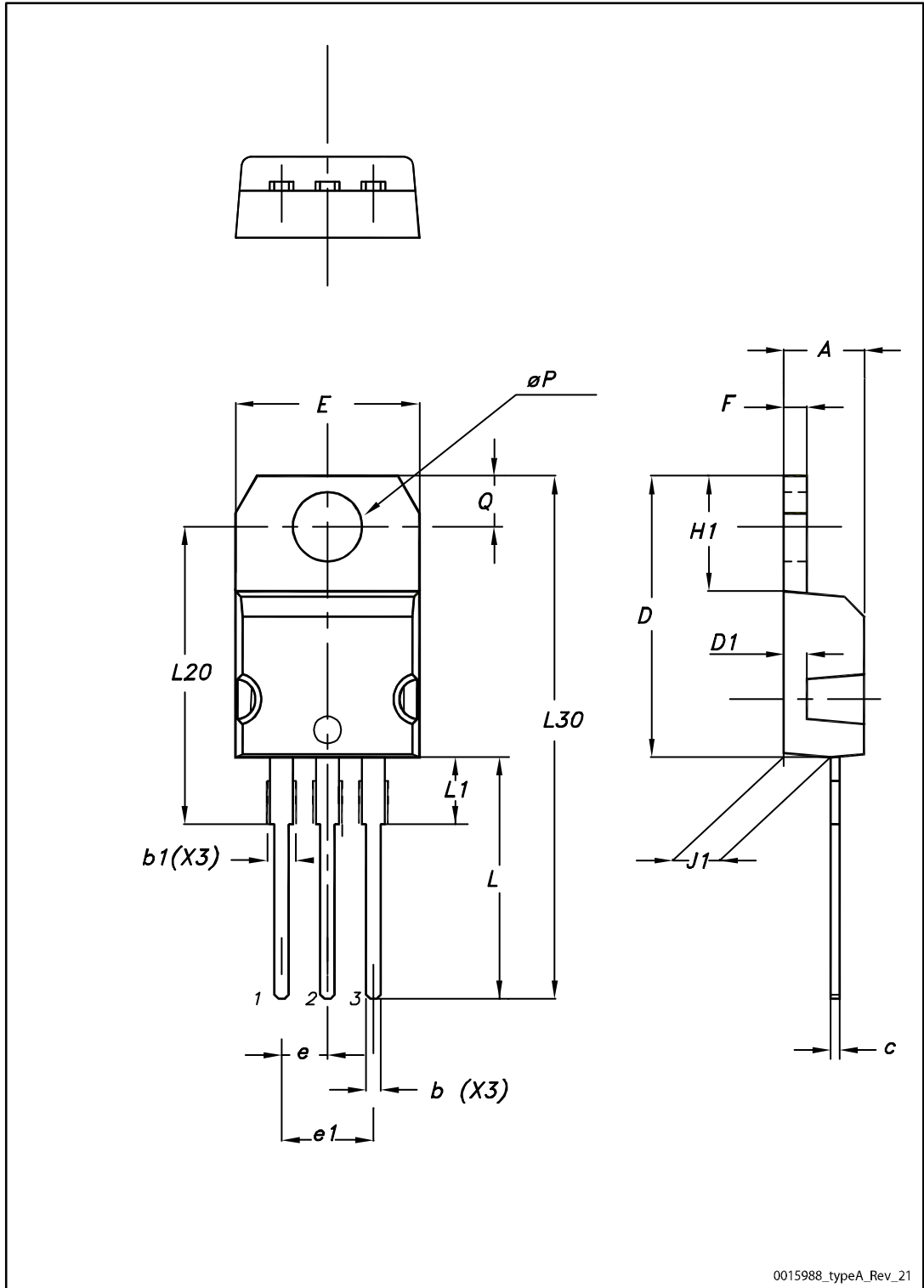


Table 10: IPAK (TO-251) type A package mechanical data

| Dim. | mm   |       |      |
|------|------|-------|------|
|      | Min. | Typ.  | Max. |
| A    | 2.20 |       | 2.40 |
| A1   | 0.90 |       | 1.10 |
| b    | 0.64 |       | 0.90 |
| b2   |      |       | 0.95 |
| b4   | 5.20 |       | 5.40 |
| B5   |      | 0.30  |      |
| c    | 0.45 |       | 0.60 |
| c2   | 0.48 |       | 0.60 |
| D    | 6.00 |       | 6.20 |
| E    | 6.40 |       | 6.60 |
| e    |      | 2.28  |      |
| e1   | 4.40 |       | 4.60 |
| H    |      | 16.10 |      |
| L    | 9.00 |       | 9.40 |
| L1   | 0.80 |       | 1.20 |
| L2   |      | 0.80  | 1.00 |
| V1   |      | 10°   |      |

### 4.2 TO-220 type A package information

Figure 23: TO-220 type A package outline



0015988\_typeA\_Rev\_21

Table 11: TO-220 type A mechanical data

| Dim. | mm    |       |       |
|------|-------|-------|-------|
|      | Min.  | Typ.  | Max.  |
| A    | 4.40  |       | 4.60  |
| b    | 0.61  |       | 0.88  |
| b1   | 1.14  |       | 1.55  |
| c    | 0.48  |       | 0.70  |
| D    | 15.25 |       | 15.75 |
| D1   |       | 1.27  |       |
| E    | 10.00 |       | 10.40 |
| e    | 2.40  |       | 2.70  |
| e1   | 4.95  |       | 5.15  |
| F    | 1.23  |       | 1.32  |
| H1   | 6.20  |       | 6.60  |
| J1   | 2.40  |       | 2.72  |
| L    | 13.00 |       | 14.00 |
| L1   | 3.50  |       | 3.93  |
| L20  |       | 16.40 |       |
| L30  |       | 28.90 |       |
| øP   | 3.75  |       | 3.85  |
| Q    | 2.65  |       | 2.95  |

## 5 Revision history

**Table 12: Document revision history**

| Date        | Revision | Changes  |
|-------------|----------|--|
| 09-Jul-2015 | 1        | Initial release  |
| 28-Jun-2016 | 2        | Updated title and features in cover page.<br>Updated <i>Section 1: "Electrical ratings"</i> .<br>Updated <i>Section 2: "Electrical characteristics"</i> .<br>Added <i>Section 2.1: "Electrical characteristics (curves)"</i> .<br>Document status promoted from preliminary to production data.<br>Minor text changes. |

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